Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10540658	MATHIES ET AL.
Examiner	Art Unit
Young J Kim	1637

SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES				
Search Notes	Date	Examiner		
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	2/8/2008	/YJK/		
see enclosed for text-search strategies	2/8/2008	/YJK/		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20080205